TOSHIBA Bipolar Linear IC Silicon Monolithic

# TA2131FNG

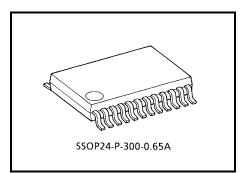
Low Current Consumption Headphone Amplifier for Portable MD Player (With Bass Boost Function)

The TA2131FNG is a low current consumption headphone amplifier developed for portable digital audio. It is particularly well suited to portable MD players that are driven by a single dry cell. It also features a built-in bass boost function with AGC, and is capable of bass amplification of DAC output and analog signals such as tuner.

#### Features

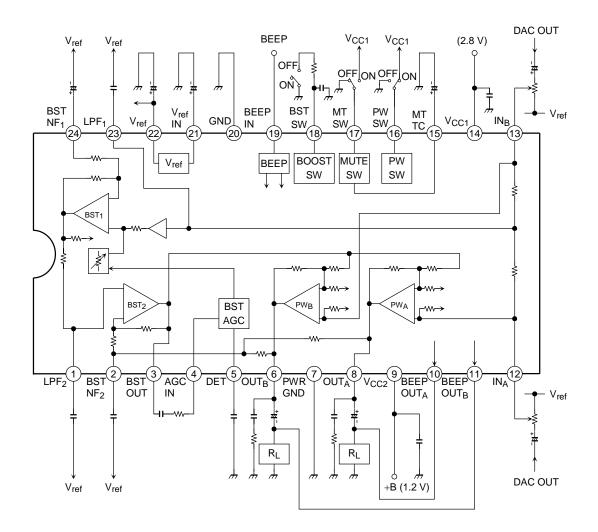
- Low current consumption: ICCQ (VCC1) = 0.55 mA (typ.) ICCQ (VCC2) = 0.20 mA (typ.)
- Output power:  $P_0 = 8 \text{ mW}$  (typ.) (V<sub>CC1</sub> = 2.8 V, V<sub>CC2</sub> = 1.2 V, f = 1 kHz, THD = 10%, R<sub>L</sub> = 16  $\Omega$ )
- Low noise:  $V_{no} = -102 dBV$  (typ.)
- Built-in low-pass boost (with AGC)
- I/O pin for beep sound
- Outstanding ripple rejection ratio
- Built-in power mute
- Built-in power ON/OFF switch
- Operating supply voltage range (Ta =  $25^{\circ}$ C): V<sub>CC1</sub> =  $1.8 \sim 4.5$  V

VCC2 = 0.9~4.5 V



Weight: 0.14 g (typ.)

### **Block Diagram**



# Terminal Explanation (Terminal voltage: Typical terminal voltage at no signal with test circuit, $V_{CC1} = 2.8 \text{ V}$ , $V_{CC2} = 1.2 \text{ V}$ , Ta = 25°C)

Te	erminal No.	Terminal Explanation	Internal Circuit	Terminal Voltage (V)
1	LPF <sub>2</sub>	BST amplifier 1 output (filter terminal)	PWA 12 20 kΩ W ADD AGC BST1 G BST2 N AMP Halvel	0.61
23	LPF <sub>1</sub>	ADD amplifier output (filter terminal)		0.61
24	BST NF1	BST amplifier 1 NF	24 1 Vref Vref	0.61
2	BST NF2	BST amplifier 2 NF terminal (low-pass compensation condenser connection terminal)		0.61
3	BST OUT	BST amplifier 2 output terminal		
6	OUTB	Power amplifier	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	0.61
8	OUT <sub>A</sub>	output	G         10 kΩ           10 kΩ         15 kΩ	
12	IN <sub>A</sub>	Power amplifier		0.61
13	IN <sub>B</sub>	input		0.01

### TA2131FNG

Te	erminal No.	Terminal Explanation	Internal Circuit	
4	AGC IN	Signal input level to BST amplifier is varied according to the input level to the boost AGC input terminal. Input impedance: $15 \text{ k}\Omega$ (typ.)	$ \begin{array}{c} 14\\  & \\  & \\  & \\  & \\  & \\  & \\  & \\  &$	0.61
5	DET	Smoothing of boost AGC level detection		
7	PWR GND	GND of power amplifier output stage		0
9	V <sub>CC2</sub>	V <sub>CC</sub> (+B) at power amplifier output stage	_	1.2
10	BEEP OUT <sub>A</sub>	Beep sound output terminal		
11	BEEP OUT <sub>B</sub>			
19	BEEP IN	Beep sound input terminal Receives beep sound signals from microcomputer.		
14	V <sub>CC1</sub>	Main V <sub>CC</sub>	_	2.8
15	MT TC	Mute smoothing Power mute switch Reduces the shock noise during switching		

### TA2131FNG

Te	Terminal No. Terminal Explanation		Internal Circuit	
16	PW SW	Power ON/OFF switch "H" level: IC operation "L" level: IC OFF Refer to function explanation 5	$V_{CC1}$ 14 16 16 16 16 16 17 16 17 16	_
17	MT SW	Mute switch "L" level: mute reset "H" level: mute ON Refer to function explanation 5	$ \begin{array}{c}                                     $	
18	BST SW	Bass boost ON/OFF switch "H" level/OPEN: BST ON "L" level: BST OFF Refer to function explanation 5		_
20	GND	GND of input stage in power amplifier	—	0
21	V <sub>ref</sub> IN	Reference voltage circuit filter terminal		0.61
22	V <sub>ref</sub>	Reference voltage circuit		0.61

#### **Function Explanation**

#### 1. Bass Boost Function

#### 1-1 Description of Operation

TA2131FNG has a bass boost function for bass sound reproduction built-in to the power amplifier. With the bass boost function, at medium levels and lower, channel A and channel B are added for the low frequency component, and output to BST amplifier 2 (BST<sub>2</sub>) in negative phase. That signal is inverted and added before being subjected to bass boost. If the signal of the low-frequency component reaches a high level, the boost gain is controlled to main a low distortion (see Fig.1).

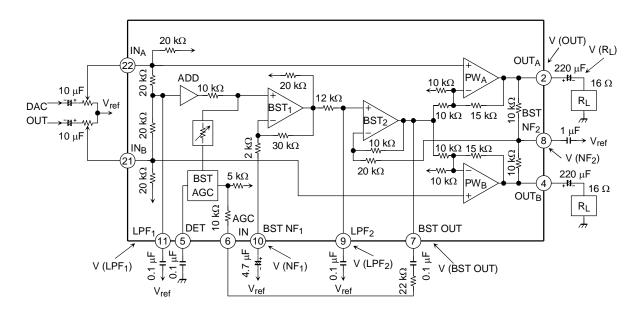


Figure 1 System Diagram of Bass Boost

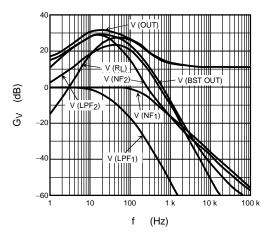
#### 1-2 AGC Circuit

The AGC circuit of the bass boost function detects with "AGC DET" the voltage component created by "BST<sub>2</sub>," and as the input level increases, the variable impedance circuit is changed, and the bass boost signal is controlled so that it is not assigned to BST amplifier 1. In this way, the bass signal to "BST<sub>2</sub>" input is shut-off, and that boost gain is controlled.

#### 1-3 Bass Boost System

As shown in Fig.1, the flow of the bass boost signal is that the signal received from power amplifier input goes through LPF<sub>1</sub>, ADD amplifier, ATT (variable impedance circuit), BPF<sub>1</sub> (BST amplifier 1) and LPF<sub>2</sub>, and the negative phase signal to the power amplifier input signal is output from BST amplifier 2. The reason why it becomes the negative phase of the BST amplifier 2 signal is that the phase is inverted by 180° in the audible bandwidth by the secondary characteristics of LPF<sub>1</sub> and LPF<sub>2</sub> in Fig.1.

Ultimately the main signal and the bass boost signal formed before  $BST_2$  are added. Fig.2 shows the frequency characteristics to each terminal.



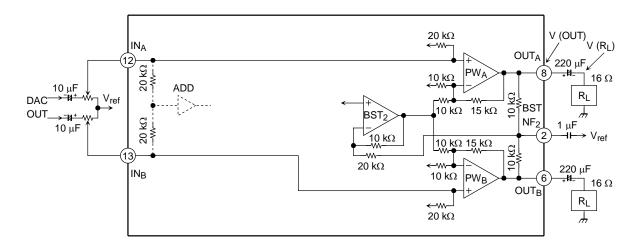
#### Figure 2 During Bass Boost (Frequency Characteristics to Each Terminal)

#### 2. Low-Pass Compensation

#### 2-1. Function

In C-couple type power amplifiers, it is necessary to give the output condenser C a large capacity to flatten out the frequency characteristics to the low frequency band (this is because the loss in the low frequency bandwidth becomes larger due to the effect of the high-pass filter comprising C and R<sub>L</sub>). Particularly when the headphone load is approximately 16  $\Omega$  and an attempt is being made to achieve frequency characteristics of ±3 dB at 20 Hz, a large capacity condenser of C = 470  $\mu$ F is required. Bearing this situation in mind, a low-pass compensation function was built in to the TA2131FNG, and while reducing the capacity of the output coupling condenser, almost flat (±3 dB) frequency characteristics in all audible bandwidths (20 Hz to 20 kHz) have been achieved.

Fig.3 shows the low-pass system diagram, and Fig.4 shows the frequency characteristics at each point. In Fig.4, (a) represents the status lost by the low-pass as a result of the high-pass filter comprising the headphone load ( $R_L = 16 \Omega$ ) and the output coupling condenser (220 µF) in the C-coupling system.



#### Figure 3 Low-Pass Compensation System Diagram

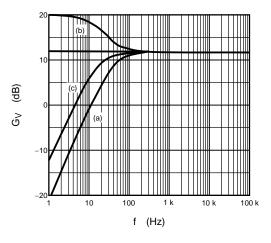


Figure 4 Power Amplifier Frequency Characteristics

<Principle of Low-Pass Compensation>

The low-pass component alone is extracted from the composite signal of  $PW_A/PW_B$  output, and that frequency signal is fed back to  $PW_A/PW_B$  once more via the inversion amplifier, thereby making it possible to increase the gain only of the low-pass component. The frequency characteristics of the power amplifier output V (OUT) in this state are shown in Fig.4 (b). In practice they are the frequency characteristics (c) viewed from load terminal V (RL), and the low-pass is compensated relative to the state in (a).

#### 2-2. Low-Pass Compensation Condenser and Crosstalk

In this low-pass compensation condenser circuit, processing is carried out using the composite signal of power amplifier output, so this affects crosstalk, according to the amount of compensation. f characteristics and crosstalk generated by the capacity of the condenser for compensation (2-pin) are shown below.

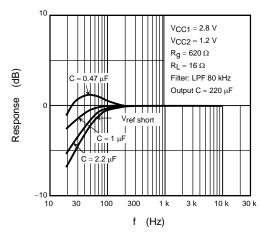


Figure 5 Condenser and f Characteristics for Low-Pass Compensation

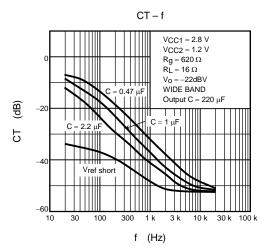
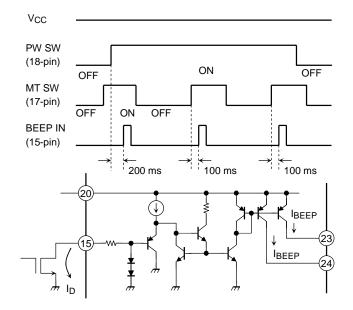


Figure 6 Low-Pass Compensation Condenser and Crosstalk

#### 3. Beep

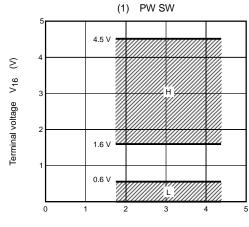
Beep sound signals from microcomputer can be received by the beep input terminal (19-pin). The PWA and PWB of the power amplifier during power mute are turned OFF, and the beep signal input from BEEP-IN (19-pin) is output from the BEEP-OUT terminal (10/11-pin) as fixed current, after passing through the converter and current amplification stage. Connecting this terminal to the headphone load outputs the beep sound.

If the beep sound is not input, fix the BEEP-IN (19-pin) terminal to GND level.

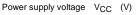


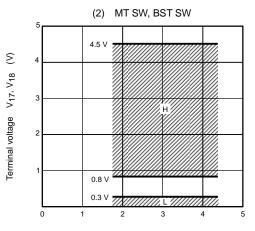
#### 4. Power Switch

As long as the power switch is not connected to "H" level, the IC does not operate. If it malfunctions due to external noise, however, it is recommended to connect a pull-down resistor externally (the power switch is set to be highly sensitive).



#### 5. Threshold Voltages of Switches





Power supply voltage  $V_{CC}$  (V)

	PW SW (V <sub>16</sub> )		
"H" level	IC operation		
"L" level	IC OFF		

	MT SW (V <sub>17</sub> )		
"H" level	Mute ON		
"L" level	Mute reset		

	BST SW (V <sub>18</sub> )
"H" level/OPEN	BST ON
"L" level	BST OFF

6. These capacitors which prevent oscillation of the power amplifier, and are between the V<sub>ref</sub> and V<sub>CC</sub>-GND must have a small temperature coefficient and outstanding frequency characteristics.

#### **Absolute Maximum Ratings**

Characteristic	Symbol	Rating	Unit	
Supply voltage	V <sub>CC</sub>	4.5	V	
Output current	I <sub>o (peak)</sub>	100	mA	
Power dissipation	P <sub>D</sub> (Note)	500	mW	
Operating temperature	T <sub>opr</sub>	-25~75	°C	
Storage temperature	T <sub>stg</sub>	-55~150	°C	

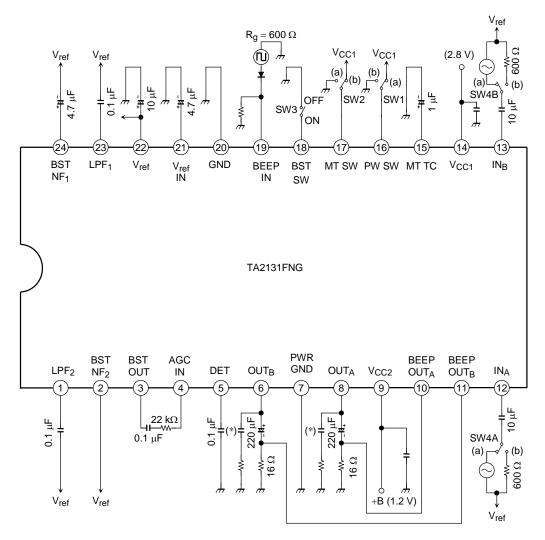
Note: Derated above  $Ta = 25^{\circ}C$  in the proportion of 4 mW/°C.

# Electrical Characteristics (Unless specified otherwise, $V_{CC1} = 2.8$ V, $V_{CC2} = 1.2$ V, $R_g = 600 \Omega$ , $R_L = 16 \Omega$ , f = 1 kHz, $Ta = 25^{\circ}$ C)

Characteristic		Symbol	Test condition	Min	Тур.	Max	Unit	
		I <sub>CC1</sub>	IC OFF (V <sub>CC1</sub> ), SW1: b, SW2: b	_	0.1	5	μA	
		I <sub>CC2</sub>	IC OFF (V <sub>CC2</sub> ), SW1: b, SW2: b	_	0.1	5	μA	
Oui	escent supply current	I <sub>CC3</sub>	MUTE ON (V <sub>CC1</sub> ), SW1: a, SW2: b	_	0.35	0.50	mA	
Qui	escent supply current	I <sub>CC4</sub>	MUTE ON (V <sub>CC2</sub> ), SW1: a, SW2: b	_	5	10	μA	
		I <sub>CC5</sub>	No signal (V <sub>CC1</sub> ), SW1: a, SW2: a		0.55	0.75		
		I <sub>CC6</sub>	No signal (V <sub>CC2</sub> ), SW1: a, SW2: a	_	0.20	0.40	m۸	
Pov	ver supply current during	I <sub>CC7</sub>	$P_0 = 0.5 \text{ mW} + 0.5 \text{ mW} \text{ output } (V_{CC1})$	_	0.6	_	mA	
driv	e	I <sub>CC8</sub>	$P_0 = 0.5 \text{ mW} + 0.5 \text{ mW} \text{ output (V}_{CC2})$	_	5.3	_		
	Gain	GV	$V_0 = -22 dBV$	10	12	14	dB	
	Channel balance	СВ	$V_0 = -22 dBV$	-1.5	0	1.5		
	Output power	Pomax	THD = 10%	5	8	_	mW	
	Total harmonic distortion	THD	P <sub>o</sub> = 1 mW	_	0.1	0.3	%	
ion	Output noise voltage	V <sub>no</sub>	$R_g = 600 \Omega$ , Filter: IHF-A, SW4: b	_	-102	-96	dBV	
Sect	Crosstalk	СТ	$V_0 = -22 dBV$	-42	-48	_		
Power Section		RR1	$f_r = 100 \text{ Hz}, V_r = -20 \text{dBV}$ inflow to $V_{CC2}$	-71	-77	_	d٩	
	Ripple rejection ratio	RR2	$f_r = 100 \text{ Hz}, V_r = -20 \text{dBV}$ inflow to $V_{CC1}$	-54	-64	_	dB	
	Mute attenuation	ATT	$V_0 = -12 dBV, SW2: a \rightarrow b$	-90	-100	—		
	Beep sound output voltage	VBEEP	V Beep IN = 2 V <sub>p-0</sub> , SW2: b	-53	-48	-43	dBV	
		BST1	$V_0 = -20$ dBV, f = 100 Hz, SW3: ON $\rightarrow$ OPEN	1	4	7		
Boo	st gain	BST2	$V_0 = -30$ dBV, f = 100 Hz, SW3: ON $\rightarrow$ OPEN	10	13	16	dB	
		BST3	$V_0 = -50$ dBV, f = 100 Hz, SW3: ON $\rightarrow$ OPEN	13.5	16.5	19.5	1	

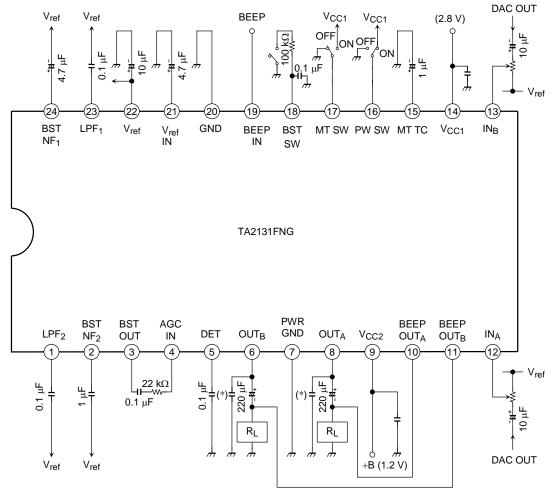
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**Test Circuit** 



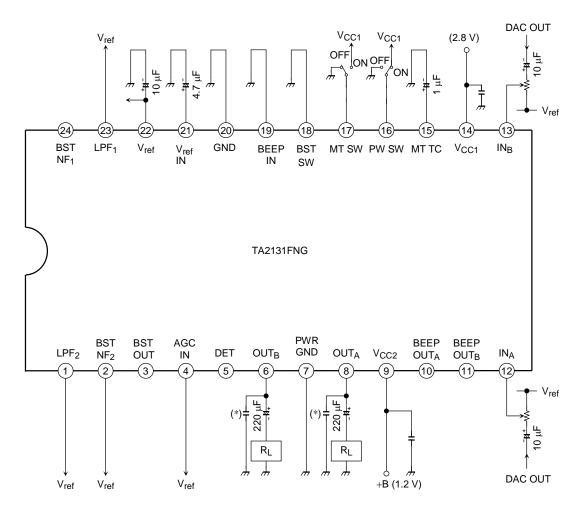
(\*) 0.22  $\mu F$  + 10  $\Omega$  Monolithic ceramic capacitor

### **Application Circuit 1**



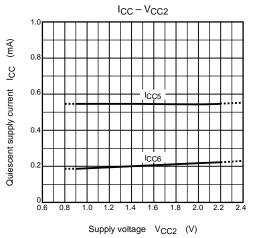
(\*) 0.22  $\mu$ F + 10  $\Omega$ Monolithic ceramic capacitor

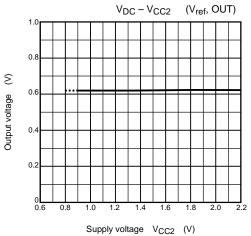
### Application Circuit 2 (Low-Pass Compensation/Bass Boost Function/Beep Not Used)

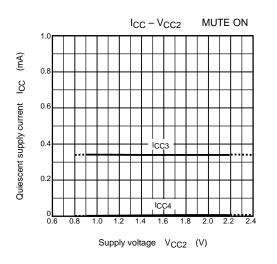


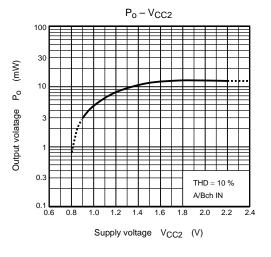
(\*)  $0.22 \ \mu F + 10 \ \Omega$ Monolithic ceramic capacitor

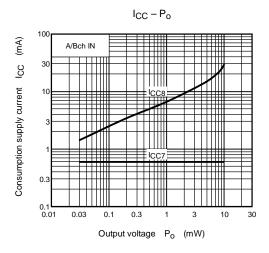
# Characteristics (Unless otherwise specified V<sub>CC1</sub> = 2.8 V, V<sub>CC2</sub> = 1.2 V, R<sub>g</sub> = 600 $\Omega$ , f = 1 kHz, Ta = 25°C)

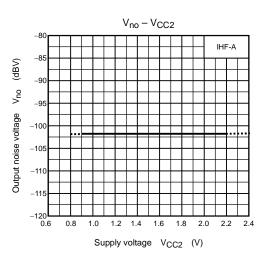


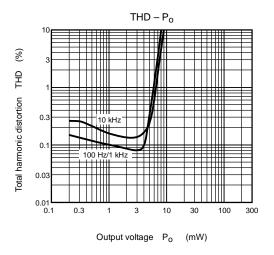


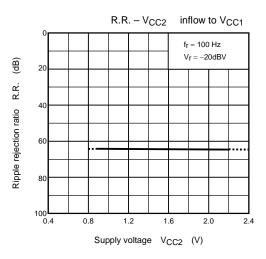


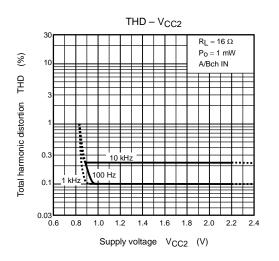


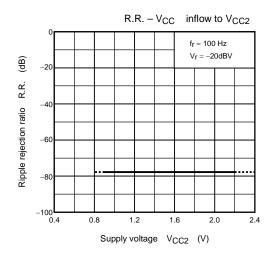


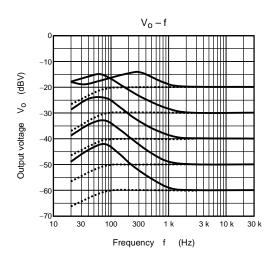


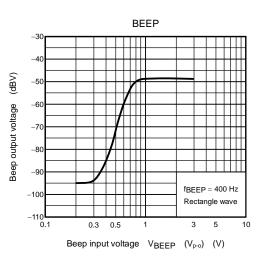


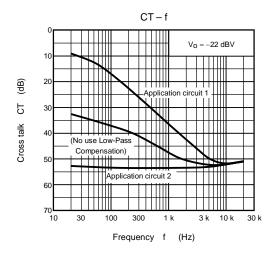


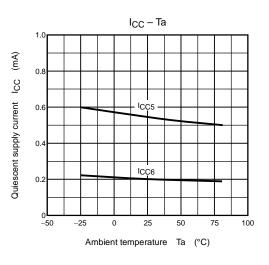


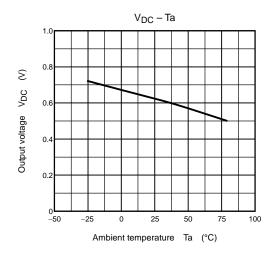




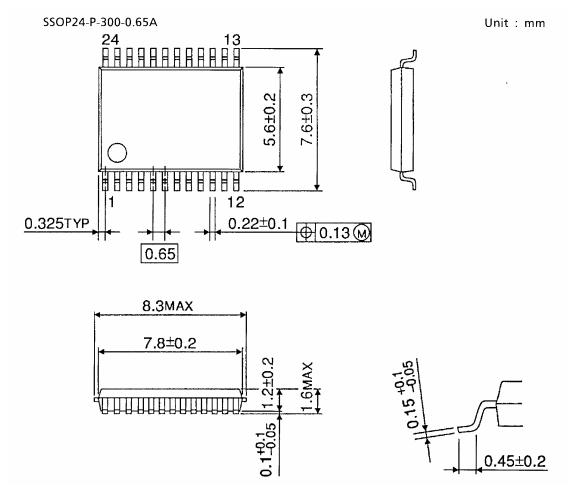








#### **Package Dimensions**



Weight: 0.14 g (typ.)

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About solderability, following conditions were confirmed

- Solderability
  - (1) Use of Sn-37Pb solder Bath
    - solder bath temperature = 230°C
    - dipping time = 5 seconds
    - the number of times = once
    - use of R-type flux
  - (2) Use of Sn-3.0Ag-0.5Cu solder Bath
    - solder bath temperature = 245°C
    - dipping time = 5 seconds
    - the number of times = once
    - use of R-type flux